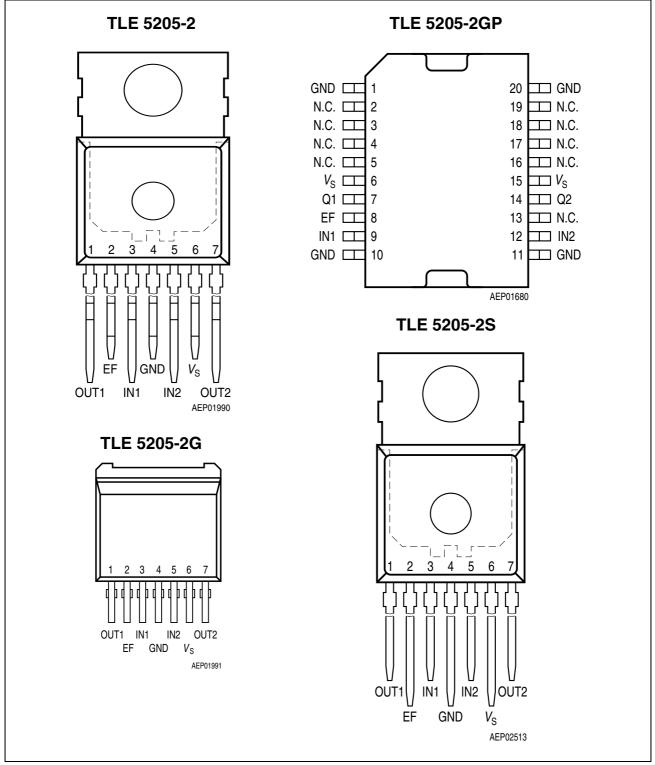


Overview

1.2 Pin Configuration (top view)







Overview

1.3 Pin Definitions and Functions

Pin No. P-TO220	Pin No. P-DSO	Symbol	Function
1	7	OUT1	Output of Channel 1; Short-circuit protected; integrated freewheeling diodes for inductive loads.
2	8	EF	Error Flag; TTL/CMOS compatible output for error detection; (open drain)
3	9	IN1	Control Input 1; TTL/CMOS compatible
4	1, 10, 11, 20	GND	Ground; internally connected to tab
5	12	IN2	Control Input 2; TTL/CMOS compatible
6	6, 15	Vs	Supply Voltage; block to GND
7	14	OUT2	Output of Channel 2; Short-circuit protected; integrated freewheeling diodes for inductive loads.
-	2, 3, 4, 5, 16, 17, 18, 19	N.C.	Not Connected



Overview

1.4 Functional Block Diagram

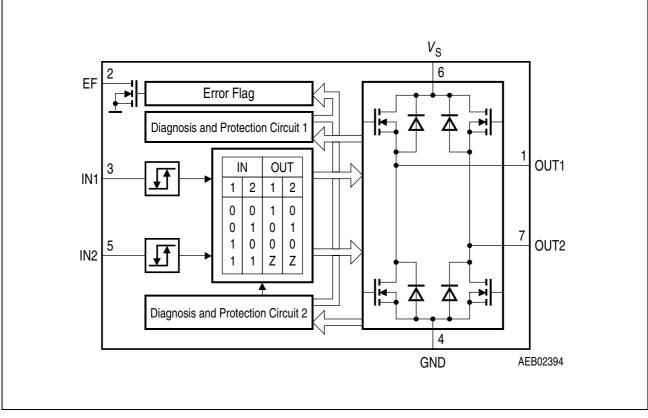


Figure 2 Block Diagram



Overview

1.5 Circuit Description

Input Circuit

The control inputs consist of TTL/CMOS-compatible schmitt-triggers with hysteresis. Buffer amplifiers are driven by this stages.

Output Stages

The output stages consist of a DMOS H-bridge. Integrated circuits protect the outputs against short-circuit to ground and to the supply voltage. Positive and negative voltage spikes, which occur when switching inductive loads, are limited by integrated freewheeling diodes.

A monitoring circuit for each output transistor detects whether the particular transitor is active and in this case prevents the corresponding source transistor (sink transistor) from conducting in sink operation (source operation). Therefore no crossover currents can occur.

1.6 Input Logic Truth Table

IN1	IN2	OUT1	OUT2	Comments
L	L	Н	L	Motor turns clockwise
L	Н	L	Н	Motor turns counterclockwise
Н	L	L	L	Brake; both low side transistors turned-ON
Н	Н	Z	Z	Open circuit detection

Functional Truth Table

Notes for Output Stage

Symbol	Value
L	Low side transistor is turned-ON High side transistor is turned-OFF
Н	High side transistor is turned-ON Low side transistor is turned-OFF
Z	High side transistor is turned-OFF Low side transistor is turned-OFF



Overview

1.7 Monitoring Functions

Undervoltage lockout (UVLO):

When $V_{\rm S}$ reaches the switch on voltage $V_{\rm S\,ON}$ the IC becomes active with a hysteresis. All output transistors are switched off if the supply voltage $V_{\rm S}$ drops below the switch off value $V_{\rm S\,OFF.}$

1.8 Protective Function

Various errors like short-circuit to + $V_{\rm S}$, ground or across the load are detected. All faults result in turn-OFF of the output stages after a delay of 50 μ s and setting of the error flag EF to ground. Changing the inputs resets the error flag.

a. Output Shorted to Ground Detection

If a high side transistor is switched on and its output is shorted to ground, the output current is internally limited. After a delay of 50 μ s all outputs will be switched-OFF and the error flag is set.

b. Output Shorted to + $V_{\rm S}$ Detection

If a low side transistor is switched on and its output is shorted to the supply voltage, the output current is internally limited. After a delay of 50 μ s all outputs will be switched-OFF and the error flag is set.

c. Overload Detection

An internal circuit detects if the current through the low side transistor exceeds the trippoint I_{SDL} . In this case all outputs are turned off after 50 µs and the error flag is set.

d. Overtemperature Protection

At a junction temperature higher than 150 °C the thermal shutdown turns-OFF, all four output stages commonly and the error flag is set with a delay.

e. Open Load Detection

The output Q1 has a 10 k Ω pull-up resistor and the output Q2 has a 10 k Ω pull-down resistor. If E1 and E2 are high, all output power stages are turned-OFF. In case of no load between Q1 and Q2 the output voltage Q1 is $V_{\rm S}$ and Q2 is ground. This state will be detected by two comparators and an error flag will be set after a delay time of 50 μ s. Changing the inputs resets the error flip flop.



Overview

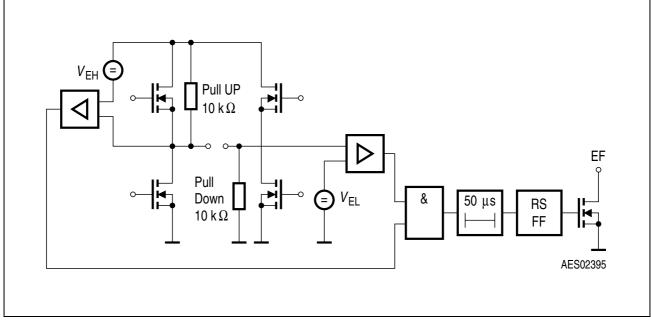


Figure 3 Simplified Schematic for Open Load Detection



Diagnosis

2 Diagnosis

Various errors as listed in the table "Diagnosis" are detected. Short circuits and overload result in turning off the output stages after a delay $t_{\rm dSD}$ and setting the error flag simultaneously [EF = L]. Changing the inputs to a state where the fault is not detectable resets the error flag (input toggling) with the exception of short circuit from OUT1 to OUT2 (load short circuit).

Flag	IN1	IN2	OUT1	OUT2	EF	Remarks	Nr.
	0	0	Н	L	1	Not detectable	1
Open circuit between OUT1 and OUT2	0	1	L	н	1	Not detectable	2
	1	0	L	L	1	Not detectable	3
	1	1	Z	Z	0		4
	0	0	V _s /2	V _s /2	0		5
Short circuit from OUT1 to OUT2	0	1	$V_{\rm s}/2$	$V_{\rm s}/2$	0		6
	1	0	L	L	1	Not detectable	7
	1	1	Z	Z	1	Not detectable	8
	0	0	GND	L	0		9
Short circuit from OUT1 to GND	0	1	GND	Н	1	Not detectable	10
	1	0	GND	L	1	Not detectable	11
	1	1	GND	L	1	Not detectable	12
	0	0	Н	GND	1	Not detectable	13
Short circuit from OUT2 to GND	0	1	L	GND	0		14
	1	0	L	GND	1	Not detectable	15
	1	1	L	GND	1	Not detectable	16
	0	0	V_{s}	L	1	Not detectable	17
Short circuit from OUT1 to V_{s}	0	1	V_{s}	Н	0		18
	1	0	V_{s}	Н	0		19
	1	1	$V_{ m s}$	н	1	Not detectable	20
	0	0	н	V_{s}	0		21
Short circuit from OUT2 to V_{s}	0	1	L	V_{s}	1	Not detectable	22
	1	0	Н	V_{s}	0		23
	1	1	Н	$V_{ m s}$	1	Not detectable	24
Overtemperature or undervoltage	0	0	Z	Z	0		25
-	0	1	Z	Z	0		26
	1	0	Z	Z	0		27
	1	1	Z	Z	0		28

IN: 0 = Logic LOW OUT: Z = Output in tristate condition

1 = Logic HIGH

= $V_{\rm s}$ /2 due to internal Pull-up/down resistors

EF: 1 = No error0 = Error

L = Output in sink condition

H = Output in source condition

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3 Electrical Characteristics

3.1 Absolute Maximum Ratings

 $-40 \ ^{\circ}\text{C} < T_{i} < 150 \ ^{\circ}\text{C}$

Parameter	Symbol	Limit Values		Unit	Remarks
		min.	max.		

Voltages

Supply voltage	Vs	- 0.3	40	V	-
		– 1	40	V	<i>t</i> < 0.5 s; <i>I</i> _S > – 5 A
Logic input voltage	V _{IN1,2}	- 0.3	7	V	0 V < V _S < 40 V
Diagnostics output voltage	V_{EF}	- 0.3	7	V	-

Currents of DMOS-Transistors and Freewheeling Diodes

Output current (cont.)	I _{OUT1,2}	- 5	5	А	-
Output current (peak)	I _{OUT1,2}	- 6	6	А	$t_{\rm p}$ < 100 ms; T = 1 s
Output current (peak)	<i>I</i> _{OUT1,2}	_	_	A	t_{p} < 50 µs; T = 1 s; internally limitted; see overcurrent

Temperatures

Junction temperature	T _j	- 40	150	°C	-
Storage temperature	T _{stg}	- 50	150	°C	_

Thermal Resistances

Junction case	R _{thjC}	-	3	K/W	P-TO220-7-11/12, P-TO263-7-1
Junction ambient	R _{thjA}	-	65	K/W	P-TO220-7-11/12
		-	75	K/W	P-TO263-7-1
Junction case	R _{thjC}	-	5	K/W	P-DSO-20-12
Junction ambient	R _{thjA}	-	50	K/W	P-DSO-20-12

Note: Maximum ratings are absolute ratings; exceeding any one of these values may cause irreversible damage to the integrated circuit.



3.2 Operating Range

Parameter	Symbol	Limit	Values	Unit	Remarks	
		min.	max.			
Supply voltage	Vs	$V_{\rm UV ON}$	40	V	After $V_{\rm S}$ rising above $V_{\rm UV ON}$	
Supply voltage increasing		- 0.3	$V_{\rm UV ON}$	V	Outputs in tristate	
Supply voltage decreasing		- 0.3	$V_{\rm UVOFF}$	V	condition	
Logic input voltage	V _{IN1,2}	- 0.3	7	V	_	
Junction temperature	T _j	- 40	150	°C	_	

3.3 Electrical Characteristics

6 V < $V_{\rm S}$ < 18 V; IN1 = IN2 = HIGH

 $I_{OUT1, 2} = 0$ A (No load); - 40 °C < T_j < 150 °C; unless otherwise specified

Parameter	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		

Current Consumption

Quiescent current	Is	-	-	10	mA	IN1 = IN2 = LOW;
						V _S = 13.2 V

Under Voltage Lockout

UV-Switch-ON voltage	V _{UV ON}	_	5.3	6	V	$V_{\rm S}$ increasing
UV-Switch-OFF voltage	$V_{\rm UVOFF}$	3.5	4.7	5.6	V	$V_{\rm S}$ decreasing
UV-ON/OFF-Hysteresis	$V_{\rm UVHY}$	0.2	0.6	_	V	$V_{\rm UV ON} - V_{\rm UV OFF}$



3.3 Electrical Characteristics (cont'd)

$6 \text{ V} < V_{\text{S}} < 18 \text{ V}; \text{ IN1} = \text{IN2} = \text{HIGH}$

 $I_{OUT1, 2} = 0$ A (No load); – 40 °C < T_{j} < 150 °C; unless otherwise specified

Parameter	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		

Outputs OUT1, 2

Static Drain-Source-On Resistance

Source I _{OUT} = - 3 A	R _{DS ON H}	_	220	350	mΩ	6 V < V _S < 18 V T _j = 25 °C
			-	500	mΩ	$6 \text{ V} < V_{\text{S}} < 18 \text{ V}$
			350	500	mΩ	$V_{\text{S ON}} < V_{\text{S}} \le 6 \text{ V}$ $T_{\text{j}} = 25 ^{\circ}\text{C}$
			_	800	mΩ	$V_{\rm SON}$ < $V_{\rm S}$ \leq 6 V
Sink I _{OUT} = 3 A	R _{DS ON L}	_	230	350	mΩ	6 V < $V_{\rm S}$ < 18 V $T_{\rm j}$ = 25 °C
			-	500	mΩ	6 V < $V_{\rm S}$ < 18 V
			400	600	mΩ	$V_{\text{S ON}} < V_{\text{S}} \le 6 \text{ V}$ $T_{\text{j}} = 25 ^{\circ}\text{C}$
			_	1000	mΩ	$V_{ m SON} < V_{ m S} \le 6 \ m V$

Note: Values of $R_{DS ON}$ for $V_{S ON} < V_S \le 6$ V are guaranteed by design.

Overcurrent

Source shutdown trippoint	$-I_{\rm SDH}$	_	_	10	А	$T_{\rm j} = -40 ^{\circ}{\rm C}$
		-	8	-	А	<i>T</i> _j = 25 °C
		6	-	-	А	<i>T</i> _j = 150 °C
Sink shutdown trippoint	I _{SDL}	-	-	10	А	$T_{\rm j} = -40 \ ^{\circ}{\rm C}$
		_	8	-	А	<i>T</i> _j = 25 °C
		6	-	-	А	<i>T</i> _j = 150 °C
Shutdown delay time	t _{dSD}	25	50	80	μs	-



3.3 Electrical Characteristics (cont'd)

6 V < $V_{\rm S}$ < 18 V; IN1 = IN2 = HIGH

 $I_{OUT1, 2} = 0$ A (No load); - 40 °C < T_{i} < 150 °C; unless otherwise specified

Parameter	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		

Short Circuit Current Limitation

Source current	$-I_{\rm SCH}$	_	_	20	А	$t < t_{dSD}$
Sink current	I _{SCL}	_	_	15	А	$t < t_{dSD}$

Open Circuit

Pull up resistor	R _{UP}	5	10	20	kΩ	-
Pull down resistor	R _{DOWN}	5	10	20	kΩ	-
Switching threshold H	V_{EH}	2	2.5	3	V	-
Switching threshold L	V_{EH}	2	2.4	3	V	-
Detection delay time	t _{dSD}	25	50	80	μs	-

Output Delay Times (Device Active for t > 1 ms)

Source ON	t _{d ON H}	_	10	20	μs	$I_{OUT} = -3 \text{ A}$ resistive load
Sink ON	t _{d ON L}	_	10	20	μs	$I_{OUT} = 3 \text{ A}$ resistive load
Source OFF	t _{d OFF H}	_	2	5	μs	$I_{OUT} = -3 \text{ A}$ resistive load
Sink OFF	t _{d OFF L}	_	2	5	μs	$I_{OUT} = 3 \text{ A}$ resistive load



3.3 Electrical Characteristics (cont'd)

$6 \text{ V} < V_{\text{S}} < 18 \text{ V}; \text{ IN1} = \text{IN2} = \text{HIGH}$

 $I_{OUT1, 2} = 0$ A (No load); – 40 °C < T_{j} < 150 °C; unless otherwise specified

Parameter	Symbol	Lir	nit Valı	Jes	Unit	Test Condition
		min.	typ.	max.		

Output Switching Times (Device Active for t > 1 ms)

Source ON	t _{on H}	_	15	30	μs	$I_{OUT} = -3 \text{ A}$ resistive load
Sink ON	t _{on L}	-	5	10	μs	$I_{OUT} = 3 \text{ A}$ resistive load
Source OFF	t _{OFF H}	_	2	5	μs	$I_{OUT} = -3 \text{ A}$ resistive load
Sink OFF	t _{OFF L}	_	2	5	μs	$I_{OUT} = 3 \text{ A}$ resistive load

Clamp Diodes

Forward Voltage

High-side	V_{FH}	-	1	1.5	V	<i>I</i> _F = 3 A
Low-side	V_{FL}	_	1.1	1.5	V	<i>I</i> _F = 3 A

Leakage Current

Source	I _{LKH}	- 100	- 50	_	μA	$OUT1 = V_S$
Sink	$I_{\rm LKL}$	_	50	100	μA	OUT2 = GND

Logic

Control Inputs IN 1, 2

H-input voltage threshold	V _{INH}	2.8	2.5	_	V	-
L-input voltage	V_{INL}	-	1.7	1.2	V	-
Hysteresis of input voltage	V_{INHY}	0.4	0.8	1.2	V	-
H-input current	I _{INH}	-2	0	2	μA	$V_{\rm IN} = 5 \ {\rm V}$
L-input current	I_{INL}	- 10	-4	0	μA	$V_{\rm IN} = 0 \ {\rm V}$



3.3 Electrical Characteristics (cont'd)

6 V < $V_{\rm S}$ < 18 V; IN1 = IN2 = HIGH

 $I_{OUT1, 2} = 0$ A (No load); - 40 °C < T_{i} < 150 °C; unless otherwise specified

Parameter	Symbol	Limit Values			Unit	Test Condition
		min.	typ.	max.		

Error Flag Output EF

Low output voltage	V_{EFL}	_	0.25	0.5	V	I _{EF} = 3 mA
Leakage current	$I_{\rm EFL}$	_	_	10	μA	$V_{EF} = 7 \ V$

Thermal Shutdown

Thermal shutdown junction temperature	T _{jSD}	150	175	200	°C	-
Thermal switch-on junction temperature	T _{jSO}	120	-	170	°C	-
Temperature hysteresis	ΔT	-	30	-	К	-
Shutdown delay time	t _{dSD}	25	50	80	μs	-

Note: Values of thermal shutdown are guaranteed by design.



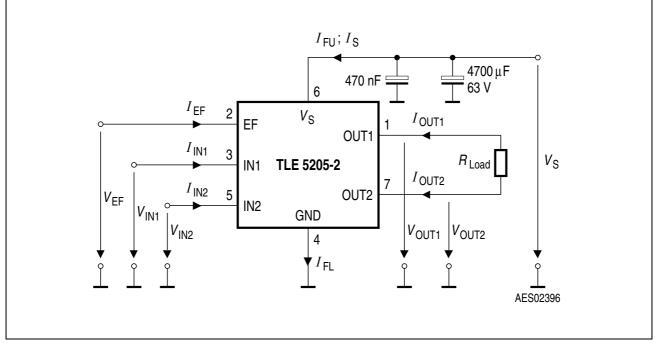


Figure 4 Test Circuit

	Overcurrent	Short Circuit	Open Circuit
I _{OUT}	I _{SD}	I _{SC}	I _{OC}



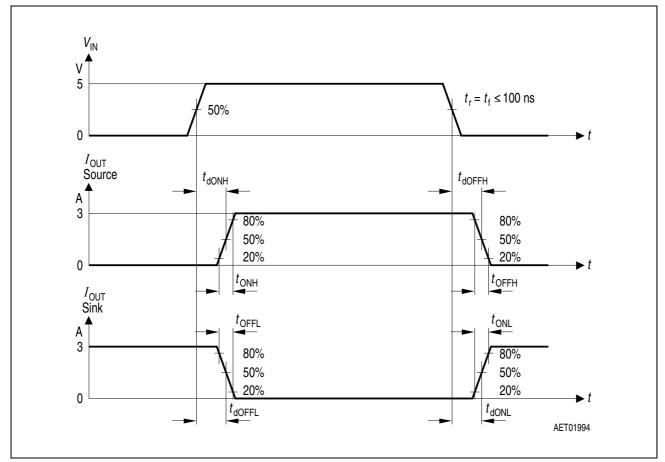


Figure 5 Switching Time Definitions

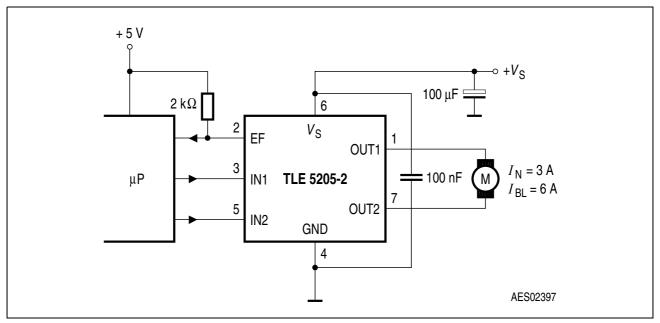


Figure 6 Application Circuit



Electrical Characteristics

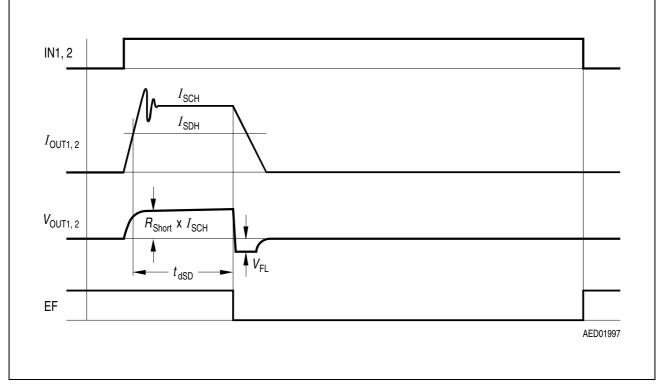


Figure 7 Timing Diagram for Output Shorted to Ground

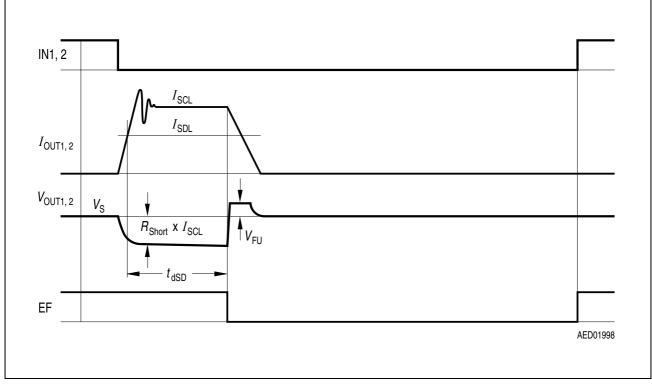
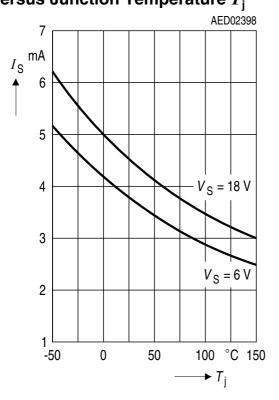


Figure 8 Timing Diagram for Output Shorted to V_{S}

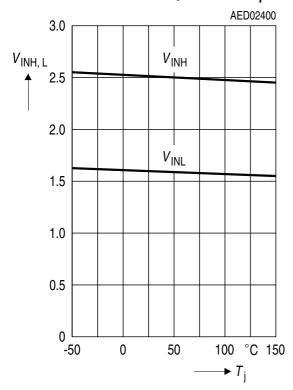


Diagrams

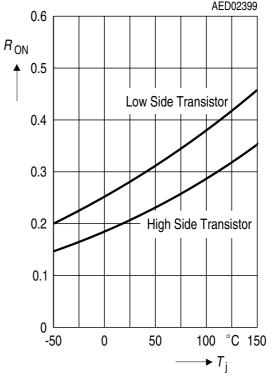
Quiescent Current I_{s} (Active) versus Junction Temperature T_{i}



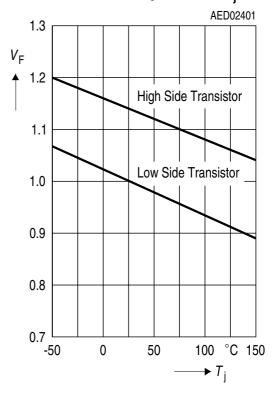
Input Switching Thresholds $V_{\text{INH, L}}$ versus Junction Temperature T_{i}



Static Drain-Source ON-Resistance versus Junction Temperature T_j

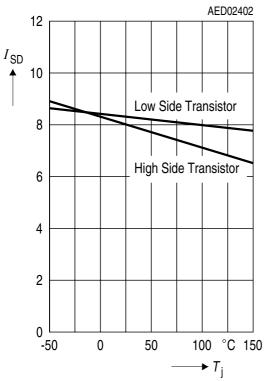


Clamp Diode Forward Voltage $V_{\rm F}$ versus Junction Temperature $T_{\rm i}$

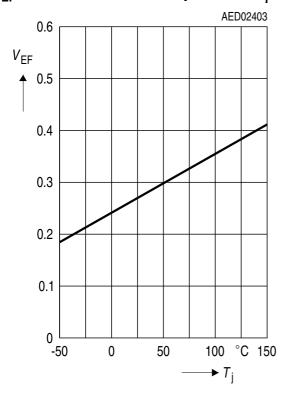


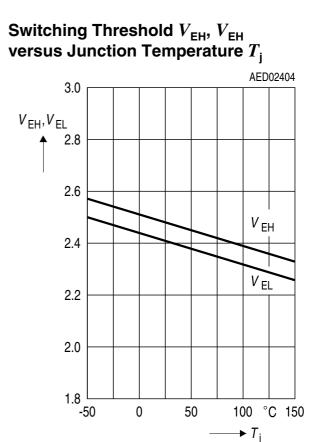






Error-Flag Saturation Output Voltage V_{EF} versus Junction Temperature T_{i}

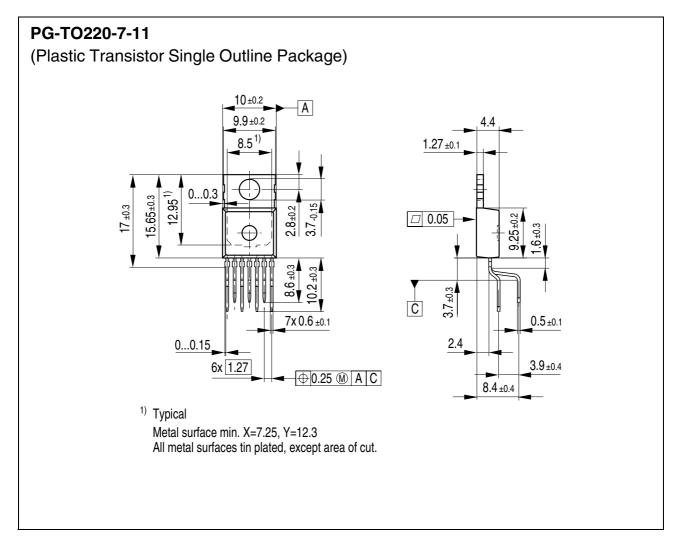






Package Outlines

4 Package Outlines



Green Product (RoHS compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

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SMD = Surface Mounted Device

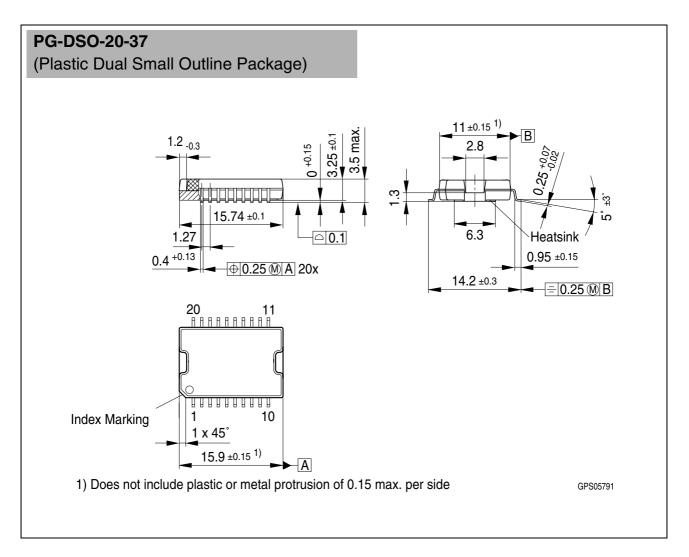
Data Sheet

Dimensions in mm

Rev. 1.1, 2007-07-31



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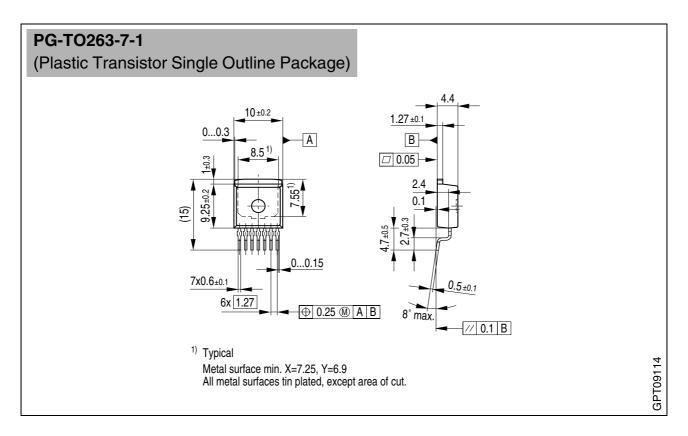
SMD = Surface Mounted Device

Data Sheet

Dimensions in mm



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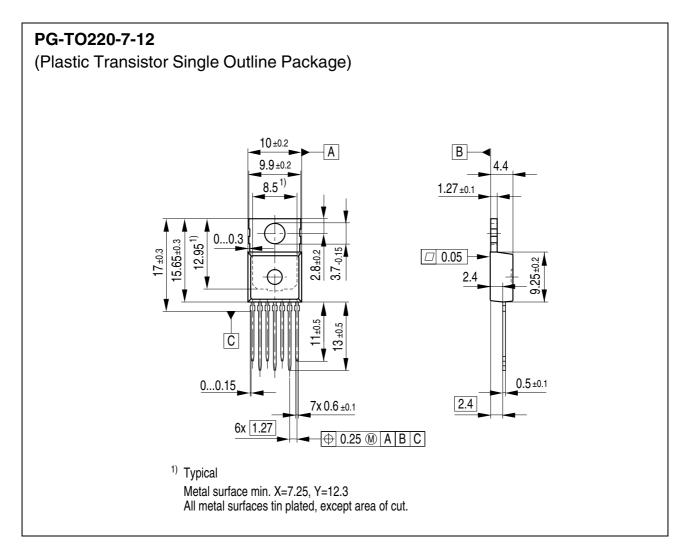
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Data Sheet

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Data Sheet

Dimensions in mm

Rev. 1.1, 2007-07-31



Revision History

5 Revision History

Version	Date	Changes
Rev. 1.1	2007-07-31	 RoHS-compliant version of the TLE 5205-2 All pages: Infineon logo updated Page 1: "AEC qualified" and "RoHS" logo added, "Green Product (RoHS compliant)" and "AEC qualified" statement added to feature list, package names changed to RoHS compliant versions, package pictures updated, ordering codes removed Page 20-23: Package names changed to RoHS compliant versions, "Green Product" description added Revision History added Legal Disclaimer added

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